

Measurement Module for Cryogenic Temperature (RTD) and Resistance

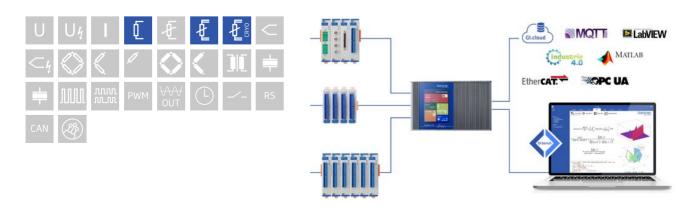
Q.raxx XL is a new addition to the Q.series product family - the ideal 19" rackmount DAQ solution for applications that require high channel density and custom sensor terminations. Q.raxx XL DAQ systems can utilize an integrated, high-performance controller for communication, control, and data logging purposes. With a controller, multiple Q.raxx XL systems can be synchronized to each other allowing for efficient DAQ distribution with low jitter and gradual expansion up to thousands of channels.

- High Density up to 13 I/O modules per Q.raxx 3U chassis with up to 16 channels per I/O module
- User Friendly front panel indicators for module status, power, and input range error
- Fully Customizable multiple front panel termination options available
- Maximum Flexibility parallel communication available in TCP/IP, CAN, PROFIBUS, Modbus, and EtherCAT
- Gantner's Quality Standard integrated filtering, galvanic isolation & signal/sensor conditioning per channel



Key Features

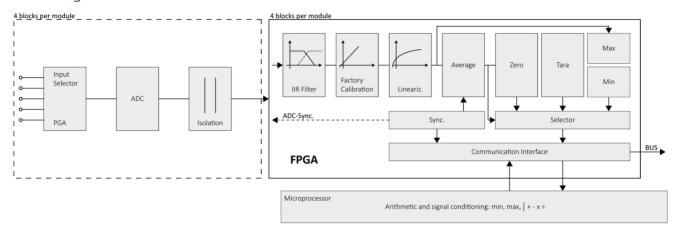
- 4 analog input channels RTD sensors, resistance 6500 Ω and 20000 Ω , 2-, 3- or 4-wire
- Low excitation current 7.5 µA effective, to minimize sensor self-heating errors
- Individual linearization of the sensor characteristics Sensor specific linearization by using 32 nodes and archive in a sensor data file. Import of manufacturers calibration data
- High-accuracy digitalization 24-bit ADC, 10 Hz sample rate per channel
- Signal conditioning linearization, filtering, average, scaling, min/max storage, RMS, arithmetic, alarm
- 3-Way galvanic isolation 500 VDC channel to channel, channel to power supply, and channel to bus





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Block diagram



Technical Data

Analog Input

Channels	4
Accuracy	0.01 % typical
	0.02 % in controlled environment ¹
	0.05 % in industrial area ²
Linearity error	0.01 % typical full-scale
Repeatability	0.003 % typical (within 24 h)
Isolation voltage	500 VDC channel to channel to power supply channel to bus ³
Sensor excitation	15 μA max. 7.5 μA effective

 $^{^{\}rm 1}$ according to EN 61326 2006: appendix B

Measurement Mode Resistance (6500 Ω)

Accuracy (4-wire)	0.65 Ω
Resolution	0.01 Ω
Temperature drift	0.5 Ω/10 Κ
Long-term stability	0.3Ω/24h 1Ω/8000h

Measurement Mode Resistance (20000 Ω)

Accuracy (4-wire)	ΖΩ
Resolution	0.03 Ω
Temperature drift	2 Ω/10 K
Long-term stability	1Ω/24h 3Ω/8000h

² according to EN 61326 2006: appendix A

 $^{^{\}rm 3}$ noise pulses up to 1000 VDC, continuous up to 250 VDC



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Example Cernox CX1050

Range	0 Ω to 6500 Ω	0 Ω to 20000 Ω
Error at 293 K (approx 70Ω)	1 % of measurement value	3 % of measurement value
Error at 100 K (approx 150 Ω)	0.5 % of measurement value	1.5 % of measurement value
Error at 5 K (approx 3500Ω)	0.02 % of measurement value	0.05 % of measurement value
Error at 2 K (approx 10000Ω)	-	0.02 % of measurement value

Example TVO CCS A1

Range	0 Ω to 6500 Ω	0 Ω to 20000 Ω
Error at 293 K (approx 850Ω)	0.075 % of measurement value	0.25 % of measurement value
Error at 100 K (approx 1160Ω)	0.06 % of measurement value	0.2 % of measurement value
Error at 5 K (approx 3900Ω)	0.02 % of measurement value	0.06 % of measurement value
Error at 2 K (approx 11000Ω)	-	0.02 % of measurement value

Analog to Digital-Conversion

Resolution	24-bit
Update rate	10 kHz, reduced by averaging to 10 Hz
Modulation method	Sigma-Delta
Anti-aliasing filter	500 Hz, 3rd order
Digital filters	Infinite impulse response (IIR), low-pass, Butterworth or Bessel (2nd, 4th, 6th or 8th order), frequency range 0.1 Hz to 10 Hz (adjustable via software)
Averaging	configurable or automatic according to the user-defined data rate

Power Supply

Input voltage	10 to 30 VDC, overvoltage and overcurrent protection
Power consumption	approx. 2.5 W
Input voltage influence	<0.001%/V

Communication Interface Localbus

Protocols	proprietary Localbus (115200 bps to 48 Mbps, latency <100 ns) ASCII (19200 bps to 115200 bps) Modbus RTU
Data format	8E1
Electrical standard	ANSI/TIA/EIA-485-A, 2-wire

Environmental

Operating temperature	-20°C to +60°C
Storage temperature	-40°C to +85°C
Relative humidity	5 % to 95 % at 50°C, non-condensing



Measurement Module for Cryogenic Temperature (RTD) and Resistance

Mechanical information

Material	Aluminum
Measurements (W x H x D)	30x 128 x 120mm
Weight	approx. 200 g

Ordering Information

Article number	614827

Gantner Instruments

Austria | Germany | France | Sweden | India | USA | China | Singapore Montafonerstraße 4 · A-6780 Schruns · T +43 55 56 · 77 463-0

office@gantner-instruments.com www.gantner-instruments.com